

PNP SILICON POWER TRANSISTORS

...designed for the output stage of 25W to 35W AF power amplifier

FEATURES:

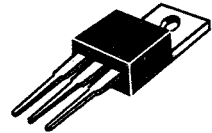
- * Low Collector-Emitter Saturation Voltage
 $V_{CE(sat)} = 2.0V(\text{Max}) @ I_C = 4.0A, I_B = 0.4A$
- * DC Current Gain
 $hFE = 40-320 @ I_C = 1.0A$
- * Complementary to NPN 2SD613

**PNP
2SB633**

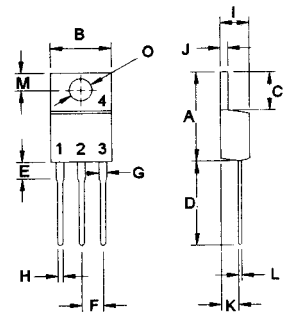
**6.0 AMPERE
POWER
TRANSISTORS
85 VOLTS
40 WATTS**

MAXIMUM RATINGS

Characteristic	Symbol	2SB633	Unit
Collector-Emitter Voltage	V_{CEO}	85	V
Collector-Base Voltage	V_{CBO}	100	V
Emitter-Base Voltage	V_{EBO}	6.0	V
Collector Current - Continuous - Peak	I_C I_{CM}	6.0 10	A
Base current	I_B	3.0	A
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	P_D	40 0.32	W W/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$



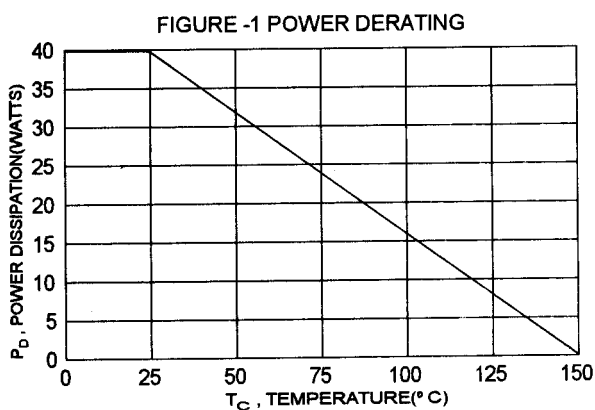
TO-220



PIN 1.BASE
2.COLLECTOR
3.EMITTER
4.COLLECTOR(CASE)

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance Junction to Case	$R_{\theta jc}$	3.125	$^\circ\text{C/W}$



DIM	MILLIMETERS	
	MIN	MAX
A	14.68	15.31
B	9.78	10.42
C	5.01	6.52
D	13.06	14.62
E	3.57	4.07
F	2.42	3.66
G	1.12	1.36
H	0.72	0.96
I	4.22	4.98
J	1.14	1.38
K	2.20	2.97
L	0.33	0.55
M	2.48	2.98
O	3.70	3.90

ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Max	Unit
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OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage ($I_C = 50 \text{ mA}, I_B = 0$)	$V_{(br)CEO}$	85		V
Collector-Base Breakdown Voltage ($I_C = 5.0 \text{ mA}, I_E = 0$)	$V_{(br)CBO}$	100		V
Emitter-Base Breakdown Voltage ($I_E = 5.0 \text{ mA}, I_C = 0$)	$V_{(br)EBO}$	6.0		V
Collector Cutoff Current ($V_{CB} = 40 \text{ V}, I_E = 0$)	I_{CBO}		100	μA
Emitter Cutoff Current ($V_{EB} = 4.0 \text{ V}, I_B = 0$)	I_{EBO}		100	μA

ON CHARACTERISTICS (1)

DC Current Gain ($I_C = 1.0 \text{ A}, V_{CE} = 5.0 \text{ V}$) * ($I_C = 3.0 \text{ A}, V_{CE} = 5.0 \text{ V}$)	$h_{FE(2)}$ h_{FE}	40 20	320	
Collector-Emitter Saturation Voltage ($I_C = 4.0 \text{ A}, I_B = 400 \text{ mA}$)	$V_{CE(sat)}$		2.0	V
Base-Emitter On Voltage ($I_C = 1.0 \text{ A}, V_{CE} = 5.0 \text{ V}$)	$V_{BE(on)}$		1.5	V

DYNAMIC CHARACTERISTICS

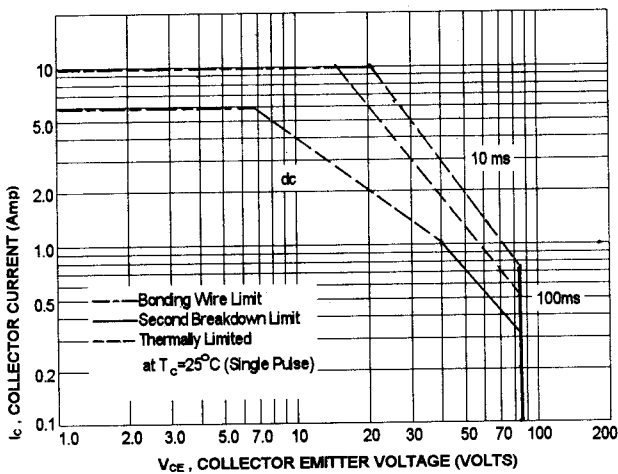
Current-Gain-Bandwidth Product ($I_C = 1.0 \text{ A}, V_{CE} = 5.0 \text{ V}, f = 1.0 \text{ MHz}$)	f_T	5.0		MHz
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(1) Pulse Test: Pulse Width = 300 μ s, Duty Cycle \leq 2.0%

* $h_{FE(2)}$ Classification :

40	C	80	60	D	120	100	E	200	160	F	320
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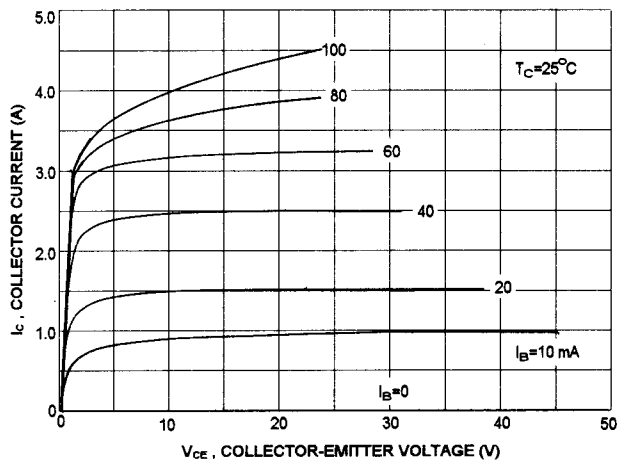
ACTIVE-REGION SAFE OPERATING AREA (SOA)



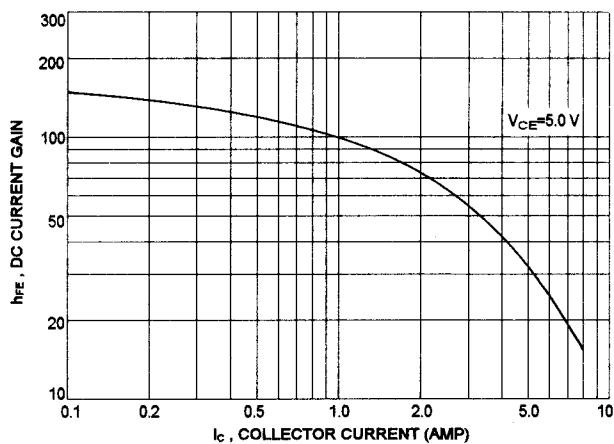
There are two limitation on the power handling ability of a transistor: average junction temperature and second breakdown safe operating area curves indicate I_C - V_{CE} limits of the transistor that must be observed for reliable operation i.e., the transistor must not be subjected to greater dissipation than curves indicate.

The data of SOA curve is base on $T_{J(PK)} = 150^\circ\text{C}$; T_c is variable depending on conditions. second breakdown pulse limits are valid for duty cycles to 10% provided $T_{J(PK)} \leq 150^\circ\text{C}$. At high case temperatures, thermal limitation will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

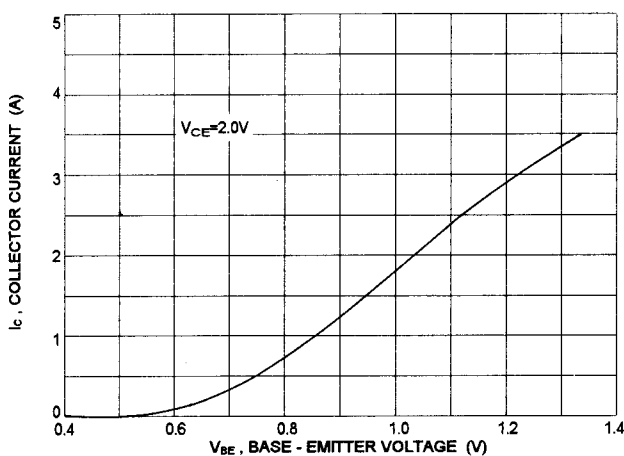
$I_c - V_{ce}$



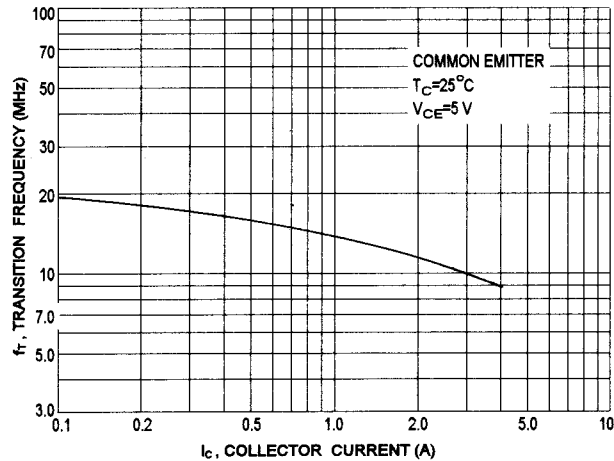
DC CURRENT GAIN



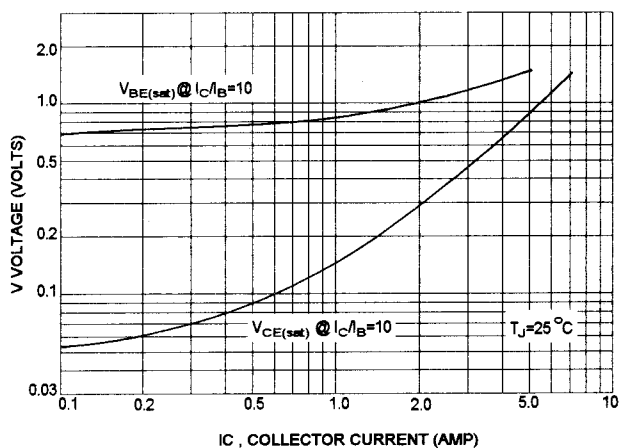
$I_c - V_{be}$



$f_T - I_c$



"ON" VOLTAGES



CAPACITANCES

